

FORM PTO-1449 (MODIFIED)  LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT	ATTORNEY DOCKET NO.	SERIAL NO.
	SP03-049A	10/823 331
	APPLICANT Bruce G. Aitken, et al.	
	FILING DATE	GROUP: 2821 2879

REFERENCE DESIGNATION				U.S. PATENT DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
JW	AA	2002/0050958	05-02-02	Dennis L. Matthies et al.	345	55	
	AB	2002/0080463	06-27-02	William L. Tonar et al.	359	267	
	AC	2002/0109136	08-15-02	Satoshi Seo et al.	257	40	
	AD	2002/0113763	08-22-02	Jun Koyama	345	87	
	AE	2002/0125822	09-12-02	Gordon L. Graff et al.	313	506	
	AF	2002/0132047	09-19-02	Shunpei Yamazaki et al.	427	255.6	
	AG	2002/0133086	09-19-02	Patrick R. Connelly et al.	600	509	
	AH	2002/0143258	10-03-02	Michael L. Weiner et al.	600	476	
	AI	2002/0149312	10-17-02	John K. Roberts et al.	313	495	
	AJ	2002/0152800	10-24-02	Petrus C.P. Bouten et al.	73	38	
JW	AK	2002/0154379	10-24-02	William L. Tonar et al.	359	267	

FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
JW	AL	WO 93/12049	06-24-93	PCT			X
	AM						
	AN						
	AO						
	AP						
	AQ						

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)		
	AR	H.E. Hagy, "A Review and Recent Developments of Photoelastic Techniques for the Measurement of Thermal Expansion Differentials Using Glass Seals", Thermal Conductivity, Vol. 24, pgs. 279-290 <i>no year or month</i>
JW	AS	H. Hirashima et al., "Electrical Conductivity of Fe <sub>2</sub> O <sub>3</sub> -V <sub>2</sub> O <sub>5</sub> -P <sub>2</sub> O <sub>5</sub> Glasses", Journal of the American Ceramic Society, Vol. 66, No. 10, October 1983, pgs. 704-708
JW	AT	H. Hirashima et al., "Effect of Basic Additive Oxides on Electrical Conductivity of Vanadate Glasses", Journal of Non-Crystalline Solids, Vol. 95 & 96, 1987, pgs. 817-824 <i>no month</i>
JW	AU	"Standard Practice for Making Reference Glass-Metal Sandwich Seal and Testing for Expansion Characteristics by Polarimetric Methods", The American Society of Testing Materials - Designation: F144-80 (Reapproved 2000), pgs. 502-506 <i>no month</i>
	AV	
	AW	

EXAMINER: *Joseph Williams* DATE CONSIDERED: *4/5/06*

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<b>FORM PTO-1449 (MODIFIED)</b>  <b>LIST OF PATENTS AND PUBLICATIONS</b> <b>FOR APPLICANTS INFORMATION</b> <b>DISCLOSURE STATEMENT</b>	<b>ATTORNEY DOCKET NO.</b>  SP03-049A	<b>SERIAL NO.</b>  10/823331
	<b>APPLICANT</b> Bruce G. Aitken, et al.	
	<b>FILING DATE</b>	<b>GROUP:</b> 2821 2879

REFERENCE DESIGNATION				U.S. PATENT DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
JW	AA	2001/0015620	08-23-01	John D. Affinito	313	512	
	AB	2001/0033135	10-25-01	Anil R. Duggal et al.	313	506	
	AC	2001/0045565	11-29-01	Shanpei Yamazaki	257	89	
	AD	2001/0048234	12-06-01	Yachin Liu et al.	297	3	
	AE	2001/0049197	12-06-01	Shunpei Yamazaki et al.	438	689	
	AF	2001/0053082	12-20-01	M.H. Chipalkatti et al.	362	496	
	AG	2001/0055841	12-27-01	Shunpei Yamazaki et al.	438	151	
	AH	2002/0003571	01-10-02	Kenneth Shofield et al.	348	148	
	AI	2002/0004577	01-10-02	Hans Biebuyck et al.	528	12	
	AJ	2002/0008463	01-24-02	William R. Roch	313	492	
JW	AK	2002/0015032	02-07-02	Jun Koyama et al.	345	204	
	AL	2002/0031874	03-14-02	Shunpei Yamazaki et al.	438	156	

FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
JW	AM	WO 00/57499	09-28-00	PCT			X
	AN	WO 01/05205	01-18-01	PCT			X
	AO	WO 01/44865	06-21-01	PCT			X
	AP	WO 02/05361	01-17-02	PCT			X
	AQ	WO 02/21557	03-14-02	PCT			X

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)		
JW	AR	Milos B. Volf, "Chemical Approach to Glass", Glass Science and Technology, Vol. 7, 1984, pg. 349, 394, 330 no month
	AS	Peter C. Schultz, "Optical Absorption of the Transition Elements in Vitreous Silica", Journal of the American Ceramic Society, Vol. 57, No. 7, pgs. 309-313 no year or month
JW	AT	"Coming® EAGLE <sup>2000</sup> ™ AMLCD Glass Substrates", MIE 201, August 2002, pgs. 1-3
JW	AU	"Coming® 1737 AMLCD Glass Substrates", MIE 101, August 2002, pgs. 1-3
JW	AV	"Laser-fabricated glass microlens arrays", Optics Letters, Vol. 23, No. 2, January 15, 1998, pgs. 141-143
JW	AW	"OLED Encapsulation", Information Display 7/02, pg. 26-28

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	APPLICANT Bruce G. Aitken, et al.	
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REFERENCE DESIGNATION				U.S. PATENT DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
JW	AA	2002/0182828	12-05-02	Taketomi Asami et al.	438	485	
	AB	2002/0187254	12-12-02	Syamal K. Ghosh et al.	427	58	
	AC	2002/0187594	12-12-02	Shunpei Yamazaki et al.	438	166	
	AD	2002/0190661	12-19-02	Anil R. Duggal et al.	315	169.1	
	AE	5,641,611	06-24-97	Chan-Long Shieh et al.	438	35	
	AF	5,693,956	12-02-97	Song Q. Shi et al.	257	40	
	AG	5,734,225	03-31-98	Hans Biebuyck et al.	313	512	
	AH	5,771,562	06-30-98	T.B. Harvey III et al.	29	592.1	
	AI	5,821,692	10-13-98	Stephen P. Rogers et al.	313	512	
	AJ	5,855,994	01-05-99	Hans Biebuyck et al.	428	209	
JW	AK	5,872,355	02-16-99	Mark R. Hueschen	250	208.1	

FOREIGN PATENT DOCUMENTS							
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REFERENCE DESIGNATION				U.S. PATENT DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
JW	AA	5,874,804	02-23-99	Stephen P. Rogers	313	512	
	AB	5,895,228	04-20-99	Hans Biebuyck et al.	438	99	
	AC	5,920,080	07-06-99	Gary W. Jones	257	40	
	AD	5,929,474	07-27-99	Rong-Ting Huang	257	292	
	AE	5,998,805	12-07-99	Song Q. Shi et al.	257	40	
	AF	6,069,443	05-30-00	Gary W. Jones et al.	313	504	
	AG	6,096,496	08-01-00	Robert D. Frankel	435	4	
	AH	6,137,221	10-24-00	Daniel B. Roitman et al.	313	504	
	AI	6,146,225	11-14-00	James R. Sheats et al.	445	24	
	AJ	6,226,890	05-08-01	Michael L. Boroson et al.	34	472	
JW	AK	6,268,695	07-31-01	John D. Affinito	313	504	

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REFERENCE DESIGNATION				U.S. PATENT DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
JW	AA	6,337,381	01-08-02	Hans Biebuyck et al.	528	12	
	AB	6,356,376	03-12-02	William L. Tonar et al.	359	267	
	AC	6,370,019	04-09-02	Dennis L. Matthies et al.	361	681	
	AD	6,436,222	08-20-02	James J. Andre et al.	156	272.8	
	AE	6,465,953	10-15-02	Anil R. Duggal	313	553	
	AF	6,470,594	10-29-02	Michael L. Boroson et al.	34	335	
	AG	2003/0066311	04-10-03	Li et al.	65	43	
	AH	3,973,975	08-10-76	Josef Francel et al.	106	53	
	AI	3,995,941	12-07-76	Shigehiro Nagahara et al.	350	160	
	AJ	4,206,382	06-03-80	Richard DeBois	313	331	
	AK						

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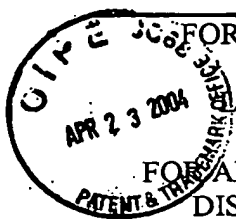
EXAMINER:

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ATTORNEY DOCKET NO.

SP03-049A

SERIAL NO.

10/823331

APPLICANT

Bruce G. Aitken, et al.

FILING DATE

4/13/2004

GROUP:

2821 2879

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub- Class	Filing Date if Approp.
	AA						
	AB						
	AC						
	AD						
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	AG						
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Sub- Class	Translation Yes No
<i>gm</i>	AL	2001-319775	11-16-01	Japan (Abstract)			X
	AM						
	AN						
	AO						
	AP						
	AQ						

## OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

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Form PTO-1449 Modified

List of Patents and Publications  
Cited by Applicant  
(Use several sheets if necessary)

Docket No.: SP03-049A

Serial No.: 10/823,331

U.S. Patent Department of Commerce  
Patent and Trademark Office

Applicant: Bruce G. Aitken et al.

Filing Date: April 13, 2004

Group: 2821-

2879

## U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Subclass
AN	A-1	5,952,778	Sep. 14, 1999	Haskal et al.	313	504
	A-2	6,566,805 B1	May 20, 2003	Tsai et al.	313	504
	A-3	6,552,488 B1	Apr. 22, 2003	Roitman et al.	313	512
	A-4	6,137,221	Oct. 24, 2000	Roitman et al.	313	504
	A-5	6,661,029 B1	Dec. 9, 2003	Duggal	257	89
	A-6	US 2003/0184219 A1	Oct. 2, 2003 (published)	Duggal et al.	313	506
	A-7	US 2002/0125484 A1	Sep. 12, 2002 (published)	Silvermail et al.	257	79
	A-8	US 2002/0097368 A1	Jul. 25, 2002 (published)	Kijima et al.	349	153
	A-9	US 6,436,739 B1	Aug. 20, 2002	Wickboldt et al.	438	149
	A-10	US 2002/0113241 A1	Aug. 22, 2002 (published)	Kubota et al.	257	79
	A-11	US 6,586,496 B1	Jul. 1, 2003	Takamatsu et al.	522	168
	A-12	US 2003/0227024 A1	Dec. 11, 2003 (published)	Yoshii et al.	257	99
	A-13	US 2003/0017297 A1	Jan. 23, 2003 (published)	Song et al.	428	68
	A-14	US 2003/0222061 A1	Dec. 4, 2003 (published)	Langer et al.	219	121.66

## FOREIGN PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Country	Translation	
					Yes	No
AN	B-1	WO 03/100832 A2	Dec. 4, 2003 (published)	PCT Patent Application		
	B-2	JP 2003-187962	July 4, 2003 (published)	Japan	x (abstract)	

Date Examined:

4/5/06

Examiner:

Joseph W. Williams

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SERIAL NO.

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SP03-049A

10/823331

INFORMAL APPLICANTS INFORMATION  
DISCLOSURE STATEMENT

## APPLICANT

Bruce G. Aitken, et al.

## FILING DATE

4/13/2004

## GROUP:

2821-2879

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub- Class	Filing Date if Approp.
<i>[Signature]</i>	AA	2004/0069017	04-15-04	Chien-Hsing Li et al.	65	43	
<i>[Signature]</i>	AB	6,733,850	05-11-04	Shinjiro Domi et al.	428	34	10-19-00
<i>[Signature]</i>	AC	6,734,615	05-11-04	T. Sugawara et al.	343	480	06-05-02
	AD						
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EXAMINER:

*Joseph W. Collins*

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	FILING DATE 4/13/2004	GROUP: 2821 2879

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
<i>AW</i>	AA	20030222061	12/4/03	Alfred Langer et al.			

FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
<i>AW</i>	AB	WO03/005774	12/16/03	PCT			

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)		

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	SP03-049A	10/823331
	APPLICANT Bruce G. Aitken, et al.	
	FILING DATE April 13, 2004	GROUP: 2879

REFERENCE DESIGNATION				U.S. PATENT DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
<i>BAW</i>	AA	6608283	8/19/2003	Liu et al.	219	121.85	
<i>BAW</i>	AB	4269617	5/26/1981	Shibuya et al.	65	43	
	AC						
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